Power MOSFETS

DATASHEET

LM30190DAQ8A

Dual N-Channel

Enhancement Mode MOSFET

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Quality Management Systems

ISO 9001:2015 Certificate

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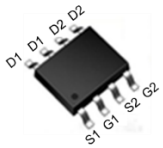
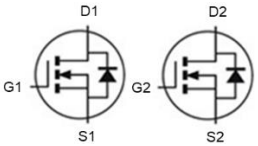
Pin Description

SOP-8L (TOP view)



Symbol



Ordering Information

Symbol	Dual N-Channel	Unit
V_{DSS}	**30**	**V**
$R_{DS(ON)-Max}$	**19**	**mΩ**
I_D	**6**	**A**

Feature

- Dual N Channel MOSFET
- Fast switching speed
- ROHS Compliant & Halogen-Free
- Reliable and Rugged
- 100% UIS Tested

Applications

- DC-DC Converters
- Portable equipment application

Ordering Information

Orderable Part Number	Package Type	Form	Shipping	Marking
LM30190DAQ8A	SOP-8	Tape & Reel	3000 / Tape & Reel	30190 □□□□□S

Absolute Maximum Ratings (T_J=25°C Unless Otherwise Noted)

Symbol	Parameter		Dual N-Channel	Unit
V_{DSS}	Drain-Source Voltage		30	V
V_{GSS}	Gate-Source Voltage		±20	
T_J	Maximum Junction Temperature		150	°C
T_{STG}	Storage Temperature Range		-55 to 150	°C
I_{DM}①	Pulse Drain Current Tested	T_A=25°C	15	A
I_D	Continuous Drain Current	T_A=25°C	6	A
		T_A=70°C	4.8	
P_D	Maximum Power Dissipation	T_A=25°C	1.1	W
		T_A=70°C	0.7	
I_{AS}②	Avalanche Current, Single pulse	L=0.1mH	14	A
E_{AS}②	Avalanche Energy, Single pulse	L=0.1mH	10	mJ

Thermal Characteristics

Symbol	Parameter		Rating	Unit
$R_{\theta JA}$③	Thermal Resistance-Junction to Ambient	t≤10s	62.5	°C/W
		Steady State	110	°C/W

Note ① : Max. current is limited by junction temperature.

Note ② : UIS tested and pulse width are limited by maximum junction temperature 150°C

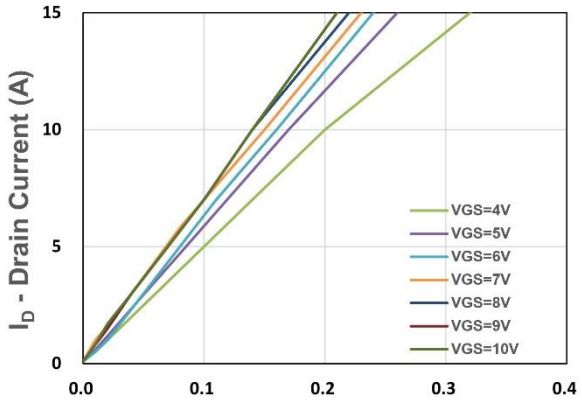
Note ③ : Surface Mounted on 1in^2 FR-4 board with 1oz.

Dual N-Channel Electrical Characteristics (T_J=25°C Unless Otherwise Noted)

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
Static Electrical Characteristics						
BV_{DSS}	Drain-Source Breakdown Voltage	V_{GS}=0V, I_{DS}=250uA	30	-	-	V
I_{DSS}	Zero Gate Voltage Drain Current	V_{DS}=24V, V_{GS}=0V	-	-	1	uA
$V_{GS(th)}$	Gate Threshold Voltage	V_{DS}=V_{GS}, I_{DS}=250uA	1	1.5	2	V
I_{GSS}	Gate Leakage Current	V_{GS}=±20V, V_{DS}=0V	-	-	±100	nA
$R_{DS(ON)}$④	Drain-Source On-state Resistance	V_{GS}=10V, I_{DS}=10A	-	16	19	mΩ
		V_{GS}=4.5V, I_{DS}=5A	-	20	26	
gfs	Forward Transconductance	V_{DS}=5V, I_{DS}=5A	-	8	-	S
Dynamic Characteristics ⑤						
R_G	Gate Resistance	V_{GS}=0V,V_{DS}=0V, Freq.=1MHz	-	3.3	-	Ω
C_{iss}	Input Capacitance	V_{GS}=0V, V_{DS}=15V, Freq.=1MHz	-	500	-	pF
C_{oss}	Output Capacitance		-	62	-	
C_{rss}	Reverse Transfer Capacitance		-	53	-	
$td_{(ON)}$	Turn-on Delay Time	V_{GS}=10V,V_{DS}=15V, I_D=1A,R_{GEN}=6Ω	-	3.2	-	nS
t_r	Turn-on Rise Time		-	21.6	-	
$t_{d(OFF)}$	Turn-off Delay Time		-	25	-	
t_f	Turn-off Fall Time		-	18.2	-	
Q_g	Total Gate Charge	V_{GS}=4.5V,V_{DS}=15V I_D=10A	-	8.5	-	nC
Q_g	Total Gate Charge	V_{GS}=10V,V_{DS}=15V, I_D=10A	-	15.4	-	
Qgs	Gate-Source Charge		-	1.3	-	
Qgd	Gate-Drain Charge		-	4.8	-	
Source-Drain Characteristics						
V_{SD}④	Diode Forward Voltage	I_{SD}=5A, V_{GS}=0V	-	0.7	1.1	V
t_{rr}	Reverse Recovery Time	I_F=5A, V_R=15V dI$_F$/dt=100A/μs	-	9	-	nS
Q_{rr}	Reverse Recovery Charge		-	3	-	nC

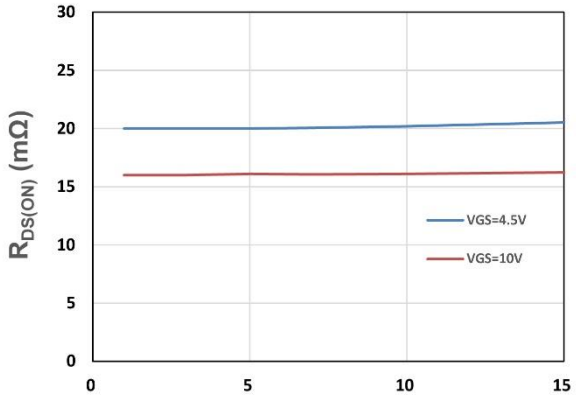
Note ④：Pulse test (pulse width≤300us, duty cycle≤2%).
Note ⑤：Guaranteed by design, not subject to production testing.

Dual N-Channel Typical Characteristics



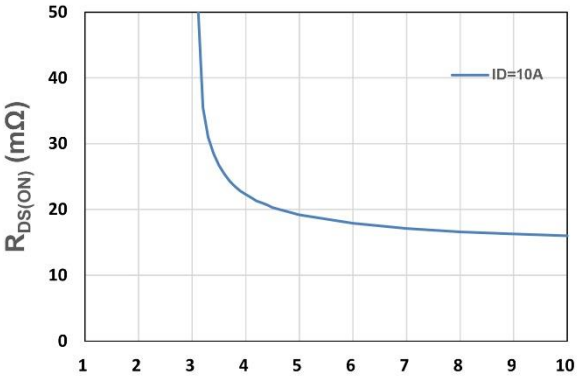
V_{DS} - Drain - Source Voltage (V)

Figure 1. Output Characteristics



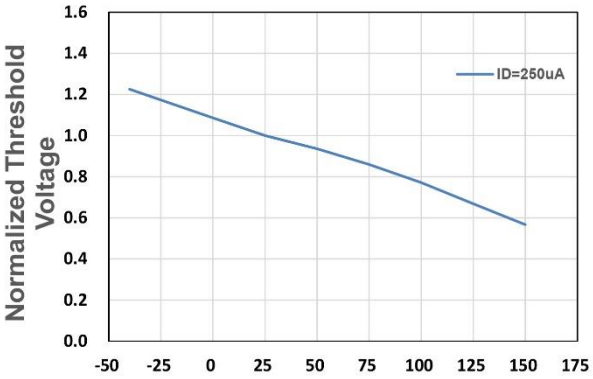
I_D- Drain Current (A)

Figure 2. On-Resistance vs. ID



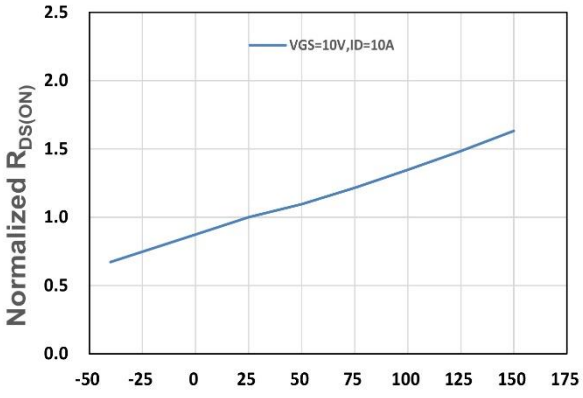
V_{GS} - Gate - Source Voltage (V)

Figure 3. On-Resistance vs. VGS



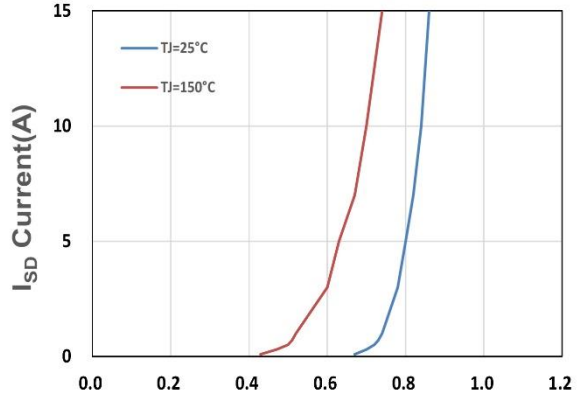
Tj, Junction Temperature(°C)

Figure 4. Gate Threshold Voltage



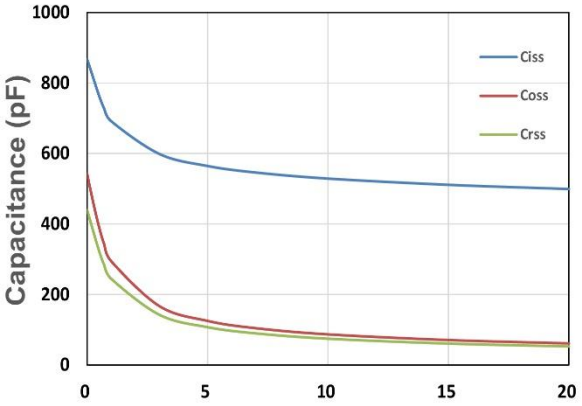
Tj, Junction Temperature(°C)

Figure 5. Drain-Source On Resistance



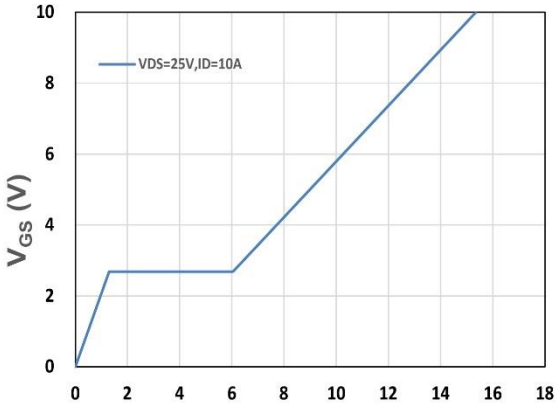
V_{SD}, Source-Drain Voltage(V)

Figure 6. Source-Drain Diode Forward



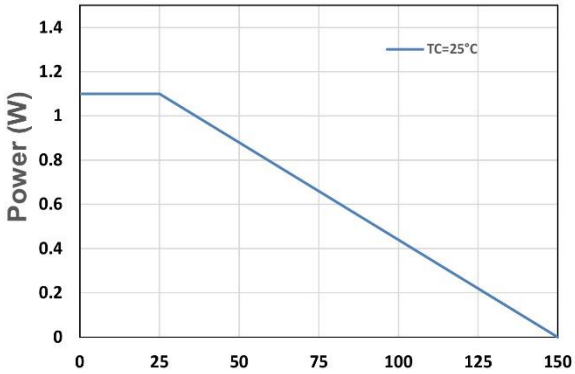
V_{DS} - Drain - Source Voltage (V)

Figure 7. Capacitance



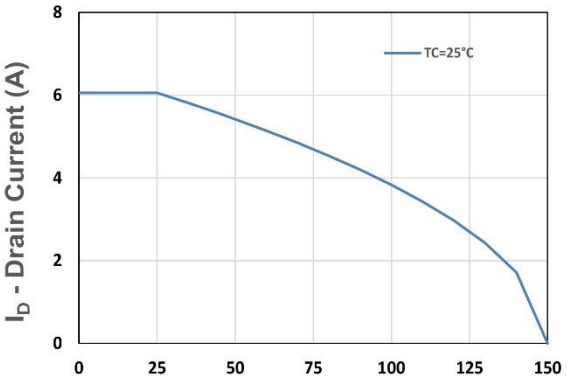
Qg, Total Gate Charge (nC)

Figure 8. Gate Charge Characteristics



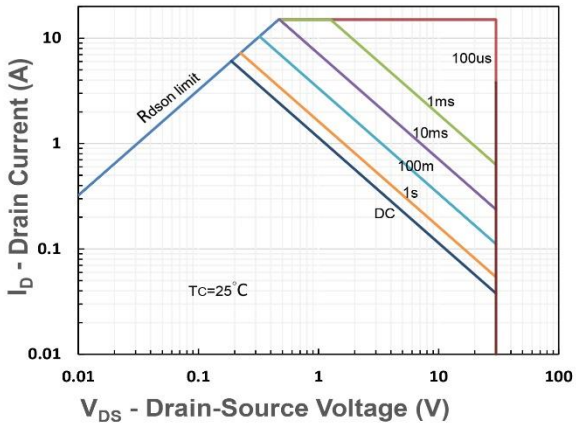
Tj - Junction Temperature (°C)

Figure 9. Power Dissipation



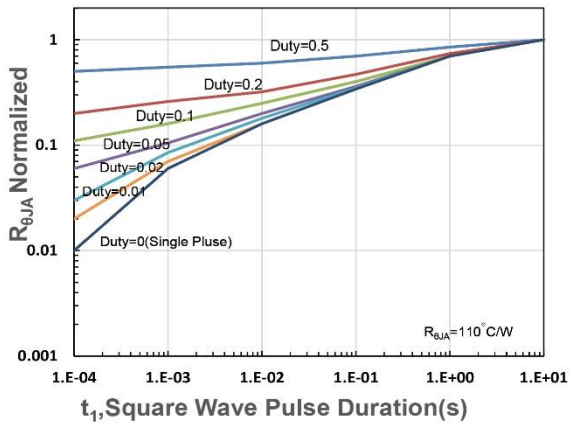
Tj - Junction Temperature (°C)

Figure 10. Drain Current



V_{DS} - Drain-Source Voltage (V)

Figure 11. Safe Operating Area



t_1,Square Wave Pulse Duration(s)

Figure 12. RθJA Transient Thermal Impedance